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Grain boundary wetting in ceramic cuprates

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Grain boundary (GB) wetting by a chemically compatible liquid in ceramic cuprates and its influence on transport properties of ceramics are considered, using model $Bi_2CuO_4-Bi_2O_3$ system as an example. It is shown that the GB wetting transition enhances significantly ionic conductivity and diffusional permeability of the ceramics. The experimental data on grain boundary wetting transition, electrical conductivity, diffusivity, and high temperature corrosion of copper are discussed. ^C *2005 Springer Science + Business Media, Inc.*

1. Introduction

During the last decade there has been a growing interest in different aspects of grain boundary (GB) wetting, stimulated by intensive development of electroceramic materials [1]. For example, high temperature superconductivity in ceramic cuprates, where GBs limit the critical current density, has been discovered [2]. Wetting of GBs can take place at the synthesis of high-temperature superconducting ceramic composites. This may have a profound effect on their electrical conductivity [3]. Ion-conducting ceramic cuprates with liquid channel grain boundary structure have been obtained [4–5]. High ionic conductivity and plasticity of ceramic cuprates with liquid channel grain boundary structure are also related to the GB wetting.

Most interesting is GB wetting by a chemically compatible liquid in the two-phase area of the bulk phase diagram where the liquid and solid are in equilibrium. In this case the interfacial tension is substantially reduced [6]. In the presented paper the GB wetting of $Bi₂CuO₄$ by eutectic liquid and its influence on transport properties are considered, $Bi₂CuO₄ - Bi₂O₃$ composite ceramics as an example. The experimental data on GB wetting transition, electrical conductivity, diffusivity are discussed.

2. Grain boundary wetting transition

The GB wetting transition in $Bi₂CuO₄$ can be realized when ceramic composite formed of $Bi₂CuO₄$ and Bi2O3 components at eutectic melting temperature between them is heated [7]. Fig. 1a shows the starting microstructure of such composite. The light phase of $Bi₂O₃$ is randomly distributed in the dark composite bulk. However, this picture can change greatly under heating. Fig. 1b and c show the microstructure of same composite, but when heated higher than the melting point of the eutectic between oxides. In this case bismuth oxide is localized on the triple grain junctions. Evidently, it is the result of the grain boundary wetting transition in $Bi₂CuO₄$ by the eutectic liquid. The kinetics transition study shows that it has stick-slip nature [8].

Most likely, that GB wetting transition is analogous to the critical point wetting studied by Chan [9–11]. According to the phase diagram of $Bi₂O₃$ -CuO system [12–13], the melting temperature of the eutectics between Bi_2CuO_4 and Bi_2O_3 is 770 \degree C. The microstructure of the solidified liquid at the triple grain junctions is presented in Fig. 2. Micrograph shows that this is a typical eutectic microstructure. In Fig. 3 the microstructure of the ceramics fracture surface is shown. The fracture is of intercrystalline nature (Fig. 3a). The grain surfaces are seen to bear eutectic traces (Fig. 3b). Note that, above solidus temperature, the ceramic composite became super plastic and may flow even due to gravity [4, 5]. It is known that one of the main conditions of super plasticity for ceramics is the presence of a liquid or glass phase along the GBs [14]. It should also be noted that the ceramic composite after cooling from temperatures above GB wetting transition has cracks (Figs 1b and c).

3. Thin intergranular films

The GB study of the ceramic $Bi_2CuO_4-Bi_2O_3$ composites cooled from temperatures above melting point of the eutectic by high resolution transmission electron microscopy showed the presence of thin intergranular films in $Bi₂CuO₄$ (Fig. 4). Thickness of intergranular films is approximately 1–2 nm. Such intergranular films were discovered in many oxide, nitride and carbide ceramics sintered with various impurities and dopants [15–21]. It was established that thickness of intergranular films is approximately constant 1–2 nm [22, 23]. This implies that the film thickness slightly depends on the GB misorientation except low angle and certain special GBs where intergranual films were not disclosed.

The equilibrium thickness of the intergranual wetting films in ceramics was calculated by Clarke [24, 25]. Within the framework of continuum approximation, Clarke proposed the approach based on the balance of forces normal to the boundary

$$
P_{\rm app} + P_{\rm cap} + \Pi_{\rm vdw} + \Pi_{\rm edl} + \Pi_{\rm st} = 0 \tag{1}
$$

Figure 1 Scanning electron micrograph of polished cross section of Bi₂CuO₄ + 20 mass% Bi₂O₃ composite ceramics (a) after cooling from 700°C, (b and c) after cooling from 780°; dark, light and black areas are Bi₂CuO₄, Bi₂O₃, and pores, respectively.

Figure 2 Microstructure of solidified liquid at triple grain junctions.

where P_{app} is the external pressure, P_{cap} is the capillary pressure, Π_{vdw} is the van der Waals pressure, Π_{edl} is the osmotic pressure due to the presence of any electrical double layer, and Π_{st} is the structural disjoining pressure. The thickness of the intergranual wetting films thus calculated is close to that obtained in experiment. Nevertheless, much should be done to elucidate whether experimentally observed intergranual films are wetting, or prewetting, or adsorption films. Most likely that these are adsorption films formed on the grain boundaries in equilibrium with the liquid phase at high temperature. Presumably, these adsorption films are left on grain boundaries after dewetting transition and retracting wetting liquid to the triple and quadruple grain junctions upon ceramics cooling. This hypothesis can be confirmed by the experimental data testifying that in many ceramics the composition of intergranular films and second phase at the triple grain junctions differs considerably [15, 18, 19, 21]. It should also be noted that the value of the thickness of wetting intergranual films, 1 nm, calculated by Clarke [24] within the framework of continuum theory of surface forces is still the matter of controversy. Derjaguin [26] showed that the applicability of continuum approximation is

Figure 3 Scanning electron micrograph of fracture surface of Bi₂CuO₄ + 20 mass% Bi₂O₃ composite ceramics after cooling from 780[°]C.

Figure 4 High resolution transmission electron micrograph of $Bi₂CuO₄$ + 20 mass% Bi₂O₃ composite ceramics after cooling from 780°C illustrating the presence of thin intergranular film.

limited in the region of spatial scales one nanometer; hence, quantitative estimates are unreliable. It remains to be established whether these thin intergranual films are truly wetting, or prewetting, or adsorption films.

Thus, upon heating of composite Bi_2CuO_4 and Bi_2O_3 based ceramics, the GB wetting transition by eutectic liquid takes place. The result is a solid/liquid composite consisting of solid matrix grains and liquid channels at the GBs. This is called a liquid channel grain boundary structure [4, 5]. The presence of continuous intergranular liquid channels can ensure high diffusional permeability and ionic conductivity of the material.

4. Transport

The GB wetting transition can affect significantly on transport properties of ceramics. Fig. 5 presents an electrical conductivity of $Bi_2CuO_4-Bi_2O_3$ composites measured versus temperature and average grain size

TABLE I Oxygen ionic conductivity (σ) and transference numbers (t_i) of Bi₂CuO₄-Bi₂O₃ composite ceramics with liquid channel grain boundary structure measured versus average grain size (d) at 770◦C.

Composition (mass $\%$)	ti	$\sigma(S/m)$	$d(\mu m)$
$Bi_2CuO_4 + 5\% Bi_2O_3$	0.02	0.12	20
$Bi_2CuO_4 + 5\% Bi_2O_3$	0.01	0.07	10
$Bi_2CuO_4 + 10\% Bi_2O_3$	0.03	0.22	20
$Bi_2CuO_4 + 10\% Bi_2O_3$	0.05	0.42	10
$Bi_2CuO_4 + 15\% Bi_2O_3$	0.14	1.26	20
$Bi_2CuO_4 + 15\% Bi_2O_3$	0.18	1.68	10
$Bi_2CuO_4 + 20\% Bi_2O_3$	0.26	2.91	20
$Bi_2CuO_4 + 20\% Bi_2O_3$	0.32	6.50	10

of $Bi₂CuO₄$ by the conventional four-point DC technique in air [27]. The curves feature jumps at 730◦ and $770\degree$ C. The first jump is caused by the polymorphic transition of α -Bi₂O₃ to δ -Bi₂O₃, which is accompanied by an abrupt increase in the oxygen ionic conductivity. The second is induced by the GB wetting transition and liquid channel grain boundary structure formation

The oxygen ionic conductivity and ion transference numbers of $Bi₂CuO₄ - Bi₂O₃$ composites measured versus average grain size of $Bi₂CuO₄$ at 780°C by Coulomb-volumetric technique are presented in the Table I [28]. The higher ionic conductivity of composites with smaller average grain size is due to higher density of intergranular liquid channels. These intergranular liquid channels can serve as diffusion ways for ions as the activation energy of ion diffusion in a liquid is lower than in a solid.

In Fig. 6 the effective diffusion coefficient of ions in the liquid channel grain boundary structure was calculated as a function of the volume fraction of the liquid phase [29]. The diffusion coefficients of ions in the liquid and solid were assumed to be 10^{-5} and 10^{-9} cm²/s, respectively. At a 15% volume fraction of liquid the effective diffusion coefficient of ions was determined to be approximately 10^{-6} cm²/s. Therefore, intergranular liquid channels give the composite high diffusional permeability and ionic conductivity.

Figure 5 Temperature (T) dependence of electrical conductivity (σ) of Bi₂CuO₄ + x Bi₂O₃ (x-5, 10, 15, and 20 mass%) composite ceramics measured versus average grain size (d) of Bi₂CuO₄ (a)-d = 20 μ m, and (b)-d = 10 μ m.

Figure 6 Effective diffusion coefficient calculated by the (1) Hart, and (2) Maxwell approaches; D_1 is the diffusion coefficient in a liquid, and *V* is the volume fraction of a solid.

Thus, GB wetting can substantially affect the transport properties of the ceramics.

5. High temperature corrosion of copper

When GB wetting occurs in the protective oxide scales on metals during high temperature corrosion, the rapid mass transport along the intergranual liquid channels results in catastrophic degradation of the metal. The GB wetting by eutectic liquid takes place in protective oxide scale containing $Bi₂CuO₄$ and $Bi₂O₃$ at high temperature oxidation of the copper-bismuth system [29, 30, 31]. As a result the copper oxidizes catastrophically. Fig. 7 presents the kinetics of copper oxidation coated with a thin film of bismuth (curve 2) and without coating (curve 1). Fig. 7 shows that the copper coated with bismuth thin film oxidizes catastrophically at 770° C. Catastrophic oxidation of copper is determined by a parabolic time law (Fig. 8), which indicates that the process is diffusion-limited.

Let us consider briefly the theory of copper catastrophic oxidation [29, 32]. Let us assume that at an instant t the protective oxide scale thickness is *h* (Fig. 9)

Figure 7 Oxidation kinetics of (1) uncoated and (2) Bi-coated (30 μ m) copper $(20 \times 20 \times 0.4 \text{ mm}^3)$; m is the mass, *S*, the copper area, *T*, the temperature, and *t*, the time.

Figure 8 Copper oxidation kinetics coated with $Bi₂O₃$ films of different thickness at $T = 800^{\circ}$ C. Film thickness $\times 10^5$ m: (1)-0; (2)-3; (3)-6; (4)-9; 10^5 k, kg²m⁻⁴s⁻¹: (1)-0.012; (2)-1.6; (3)-4.9; and (4)-21.

Figure 9 Schematic of protective oxide scale with liquid channel grain boundary structure formed on the $Bi₂O₃$ —coated copper during high temperature corrosion.

and it is large in comparison with distances over which the effect of the space charge is felt. The rate of copper oxidation is limited by diffusion of oxygen ions along the liquid intergranular channels. Oxygen concentration in the corrosion product is c^* . We shall ignore oxygen dissolution in the metal. Then the mass balance equation can be written as

$$
c^*(\mathrm{d}h/\mathrm{d}t) = J \tag{2}
$$

where *J* is the oxygen density flux.

$$
J = -D(dc/dx)
$$
 (3)

where *D* is the effective diffusion coefficient of oxygen in the liquid channel grain boundary structure, and *c* is oxygen concentration. Let us assume that oxygen diffusion takes place at permanent boundary conditions (stationary problem)

$$
c(x = 0, t) = c_1; \quad c(x = h, t) = c_0 \tag{4}
$$

Assuming a linear distribution of oxygen concentration in the channel, one obtains

$$
dc/dx = (c_1 - c_0)/h \tag{5}
$$

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The oxygen concentration c_0 is close to zero. In view of this we obtain

$$
dc/dx = c_1/h \tag{6}
$$

Substituting expression (6) in (3) we will have

$$
J = -D(c_1/h) \tag{7}
$$

In view of (7) the equation of mass balance (2) will have the following form

$$
c^*(\mathrm{d}h/\mathrm{d}t) = -D\left(\frac{c_1}{h}\right) \tag{8}
$$

Separation of the variables in Equation 8 and integration gives a parabolic law for copper oxidation

$$
h^2 = Kt \tag{9}
$$

where is the rate constant.

$$
K = 2D\left(c_1/c^*\right) \tag{10}
$$

In actual practice, for calculation, the formula with the dimensions kg²m⁻⁴s⁻¹ is more suitable

$$
K = 2D \rho^2 (c_1/c^*)
$$
 (11)

where ρ is the protective oxide density. The calculated *K* ≈ 5.2 × 10⁻⁴ kg²/(m⁴s) [29] at c_1 ≈ 0.03 and c^* ≈ 0.5 (in atomic fraction), $D \approx 10^{-10}$ m²/s, and $\rho \approx$ 6.5×10^3 kg/m³ and experimental $K = 2.1 \times 10^{-4}$ kg $\frac{2}{m^4s}$ [30, 31] values of the rate constant of catastrophic oxidation of copper are of the same order of magnitude, which testifies to the compliance of the theory and experiment. Just for comparison, the oxidation rate constant $K = 1.2 \times 10^{-7} \text{ kg}^2/(\text{m}^4\text{s})$ [30] for noncoated copper is over three orders less. The GB wetting enhances greatly the transport properties of the protective oxide scales formed on the metal at high temperature corrosion.

6. Conclusions

1. Thus, on the basis of the presented experimental data we can conclude that the GB wetting transition in ceramic composite based on $Bi₂CuO₄$ and $Bi₂O₃$ takes place at the melting point of the eutectic between them.

2. The GB wetting transition enhances substantially ionic conductivity and diffusional permeability of the ceramic composite.

3. The ceramic composites with liquid channel grain boundary structure could have applications as ion transport membranes in electrochemical devices such as solid oxide fuel cells, ceramic membrane reactors and oxygen separators.

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